Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/654,956	PHILP ET AL.	
Examiner	Art Unit	
Matthow D. Matzek	1771	

	SEAR	CHED	
Class	Subclass	Date	Examiner
442	2, 12,14,16	12/30/05	мм

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		-		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
105	12/30/05	мм		
ASSIGNEE/ INVENTER	12/30/05	мм		
EAST	12/30/0)	мм		